Appl. No

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## AMENDMENTS TO THE CLAIMS

The claims as listed below will replace all prior listings and presentations of claims in the above-identified application.

## Please amend Claims 6 and 12, and add new Claims 20-40 as indicated below:

- 1. (ORIGINAL) A capacitor structure, comprising:
  - a base layer;
  - a bottom electrode formed over the base layer;
- a BST film formed over the bottom electrode, the BST film having a substantially uniform crystal orientation; and
  - a top electrode formed over the BST film

wherein the BST film comprises between about 50 and 53.5 atomic percent titanium.

- 2. (ORIGINAL) The capacitor structure of Claim 1, wherein the BST film comprises between about 52 and 53 atomic percent titanium.
- 3. (ORIGINAL) The capacitor structure of Claim 1, wherein the base layer comprises polysilicon.
- 4. (ORIGINAL) The capacitor structure of Claim 1, wherein the bottom electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
- 5. (ORIGINAL) The capacitor structure of Claim 1, wherein the top electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
  - 6. (CURRENTLY AMENDED) A capacitor structure, comprising: a base layer;
  - a first nucleation layer formed over the base layer and selected to induce a substantially uniform crystal orientation in subsequent layers formed thereon;
    - a bottom electrode formed over the nucleation layer;
    - a second nucleation layer formed over the bottom electrode;
  - a BST film formed over the second nucleation layer, the BST film having a substantially uniform crystal orientation; and
    - a top electrode formed over the BST film.

7. (ORIGINAL) The capacitor structure of Claim 6, wherein the first nucleation layer is made of NiO.

- 8. (ORIGINAL) The capacitor structure of Claim 6, wherein the bottom electrode is made of platinum.
- 9. (ORIGINAL) The capacitor structure of Claim 6, wherein the second nucleation layer is made of a material selected from the group consisting of Ti, Nb, and Mn.
- 10. (ORIGINAL) The capacitor structure of Claim 6, wherein the top electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
- 11. (ORIGINAL) The capacitor structure of Claim 6, wherein the BST film comprises about 52-53 atomic percent titanium.
  - 12. (CURRENTLY AMENDED) A capacitor structure, comprising:
    - a base layer;
    - a bottom electrode formed over the base layer;
  - a first nucleation layer made consisting essentially of a metal formed over the bottom electrode;
  - a BST film formed over the first nucleation layer, the BST film having a substantially uniform crystal orientation; and
    - a top electrode formed over the BST film.
- 13. (ORIGINAL) The capacitor structure of Claim 12, wherein the first nucleation layer is a material selected from the group consisting of Ti, Nb and Mn
- 14. (ORIGINAL) The capacitor structure of Claim 12, wherein the BST film comprises between about 50 and 53.5 atomic percent titanium.
- 15. (ORIGINAL) The capacitor structure of Claim 12, further comprising a second nucleation layer between the base layer and the bottom electrode.
- 16. (ORIGINAL) The capacitor structure of Claim 15, wherein the second nucleation layer is made of NiO.
- 17. (ORIGINAL) The capacitor structure of Claim 12, wherein the base layer comprises polysilicon.

- 18. (ORIGINAL) The capacitor structure of Claim 12, wherein the bottom electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
- 19. (ORIGINAL) The capacitor structure of Claim 12, wherein the top electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
  - 20. (NEW) A capacitor structure, comprising:
    - a base layer;
    - a first nucleation layer made of NiO formed over the base layer;
    - a bottom electrode formed over the nucleation layer;
    - a second nucleation layer formed over the bottom electrode;
  - a BST film formed over the second nucleation layer, the BST film having a substantially uniform crystal orientation; and
    - a top electrode formed over the BST film.
- 21. (NEW) The capacitor structure of Claim 20, wherein the bottom electrode is made of platinum.
- 22. (NEW) The capacitor structure of Claim 20, wherein the second nucleation layer is made of a material selected from the group consisting of Ti, Nb, and Mn.
- 23. (NEW) The capacitor structure of Claim 20, wherein the bottom and top electrodes are selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
- 24. (NEW) The capacitor structure of Claim 20, wherein the BST film comprises about 52-53 atomic percent titanium.
  - 25. (NEW) A capacitor structure, comprising:
    - a base layer;
    - a bottom electrode formed over the base layer;
  - a first nucleation layer made of a metal formed over the bottom electrode, the first nucleation layer being a material selected from the group consisting of Ti, Nb and Mn;
  - a BST film formed over the first nucleation layer, the BST film having a substantially uniform crystal orientation; and

a top electrode formed over the BST film.

- 26. (NEW) The capacitor structure of Claim 25, wherein the BST film comprises between about 50 and 53.5 atomic percent titanium.
- 27. (NEW) The capacitor structure of Claim 25, further comprising a second nucleation layer between the base layer and the bottom electrode.
- 28. (NEW) The capacitor structure of Claim 27, wherein the second nucleation layer is made of NiO.
- 29. (NEW) The capacitor structure of Claim 25, wherein the base layer comprises polysilicon.
- 30. (NEW) The capacitor structure of Claim 25, wherein the bottom and top electrodes are selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
  - 31. (NEW) A capacitor structure, comprising:
    - a base layer;
    - a bottom electrode formed over the base layer;
    - a first nucleation layer made of a metal formed over the bottom electrode;
    - a second nucleation layer between the base layer and the bottom electrode;
  - a BST film formed over the first nucleation layer, the BST film having a substantially uniform crystal orientation; and
    - a top electrode formed over the BST film.
- 32. (NEW) The capacitor structure of Claim 32, wherein the second nucleation layer is made of NiO.
- 33. (NEW) The capacitor structure of Claim 32, wherein the first nucleation layer is a material selected from the group consisting of Ti, Nb and Mn
- 34. (NEW) The capacitor structure of Claim 32, wherein the BST film comprises between about 50 and 53.5 atomic percent titanium.
- 35. (NEW) The capacitor structure of Claim 32, wherein the bottom and top electrodes are selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.

36. (NEW) A capacitor structure, comprising:

a base layer;

- a bottom electrode formed over the base layer;
- a BST film formed over the bottom electrode, the BST film having a substantially uniform crystal orientation; and
  - .a top electrode formed over the BST film;

wherein the BST film comprises between about 50 and 53.5 atomic percent titanium and substantially the same crystal orientation as the bottom electrode.

- 37. (NEW) The capacitor structure of Claim 36 wherein the BST film comprises between about 52 and 53 atomic percent titanium.
- 38. (NEW) The capacitor structure of Claim 36, wherein the base layer comprises polysilicon.
- 39. (NEW) The capacitor structure of Claim 36, wherein the bottom electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.
- 40. (NEW) The capacitor structure of Claim 36, wherein the top electrode is selected from the group of materials consisting of Pt, Ru, Ir, IrO<sub>x</sub>, RuO<sub>x</sub> Pt-Rh, Mo and Pd.